Searcn Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/796,282	JUNG ET AL.	
Examiner	Art Unit	
HUNG Q. DANG	2621	

	SEARCHED			
Class	Subclass	Date	Examiner	
386	95, 97, 112	2/29/2008	HQD	
715	716	2/29/2008	HQD	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Inventors' Names Search	7/17/2007	HQD
USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB (see Search History attached)	7/11/2007- 7/17/2007	HQD
consulted with Thai Tran	7/16/2007	HQD